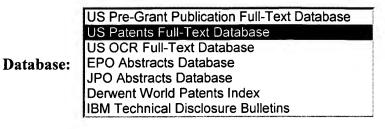
Refine Search

Search Results -

Terms	Documents
L3	54

7.29.4



Search:



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Set Name Query side by side	Hit Count	Set Name result set
DB=USPT; $PLUR=YES$; $OP=OR$		
<u>L4</u> L3	54	<u>L4</u>
DB = PGPB, $USPT$, $USOC$, $EPAB$, $JPAB$, $DWPI$, $TDBD$; $PLUR = YD$	ES; $OP = OR$	
<u>L3</u> checksum and LDAP	141	<u>L3</u>
<u>L2</u> (director\$3 near service) same checksum	4	<u>L2</u>
<u>L1</u> ("X.500") same (director\$3 near service) same checksu	ım 1	<u>L1</u>

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Search Results -

Terms	Documents
L5 not L3	1

4021

US Pre-Grant Publication Full-Text Databas	se
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L6	Refine Search
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DB=PGPB	R, USPT, USOC, EPAB, JPAB, DWPI, TDBD; PLUR =	YES; OP = OR	
<u>L6</u>	L5 not L3	1	<u>L6</u>
<u>L5</u>	L4 and (fingerprint or (finger near print))	40	<u>L5</u>
. <u>L4</u>	L1 and (checksum or (check near sum))	87	<u>L4</u>
<u>L3</u>	L2 and (fingerprint or (finger near print))	39	<u>L3</u>
<u>L2</u>	L1 and checksum	77	<u>L2</u>
<u>L1</u>	X.500	705	<u>L1</u>

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1 XML on LDAP network database

Law, K.L.E.;

Electrical and Computer Engineering, 2000 Canadian Conference on , Volume 1 , 7-10 March 2000

Pages:469 - 473 vol.1

[Abstract] [PDF Full-Text (368 KB)] IEEE CNF

2 Hospital financial electronic reporting

Mowat, J.; Gong Zhang; Wieler, J.;

Electrical and Computer Engineering, 2002. IEEE CCECE 2002. Canadian

Conference on , Volume: 2 , 12-15 May 2002

Pages:1205 - 1210 vol.2

[Abstract] [PDF Full-Text (542 KB)] IEEE CNF

3 LDAP and the grid

Gietz, P.;

Cluster Computing and the Grid 2nd IEEE/ACM International Symposium CCGRID2002 , 21-24 May 2002

Pages:3 - 3

[Abstract] [PDF Full-Text (176 KB)] IEEE CNF

⁴ Managing complex and varied data with the IndexFabric[™]

Sample, N.; Cooper, B.; Franklin, M.; Hjaltason, G.; Shadmon, M.; Cohen, L., Data Engineering, 2002. Proceedings. 18th International Conference on , 26 I March 2002

b e

Pages:492 - 493

[Abstract] [PDF Full-Text (302 KB)] IEEE CNF

5 Distributed evaluation of network directory queries

Amer-Yahia, S.; Divesh Srivastava; Suciu, D.;

Knowledge and Data Engineering, IEEE Transactions on , Volume: 16 , Issue:

4, April 2004

Pages: 474 - 486

[Abstract] [PDF Full-Text (614 KB)] IEEE JNL

6 Hierarchical or relational? A case for a modern hierarchical data mo Jagadish, H.V.; Lakshmanan, L.V.S.; Srivastava, D.; Knowledge and Data Engineering Exchange, 1999. (KDEX '99) Proceedings. 1

Workshop on , 7 Nov. 1999 Pages: 3 - 10

[Abstract] [PDF Full-Text (188 KB)] IEEE CNF

7 MetaComm: a meta-directory for telecommunications

Freire, J.; Lieuwen, D.; Ordille, J.; Garg, L.; Holder, M.; Urroz, H.; Michael, G Orbach, J.; Tucker, L.; Ye, Q.; Arlein, R.;

Data Engineering, 2000. Proceedings. 16th International Conference on , 29 I March 2000

Pages: 211 - 219

[Abstract] [PDF Full-Text (84 KB)] IEEE CNF

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1 Heterogeneous query processing through SQL table functions

Reinwald, B.; Pirahesh, H.; Krishnamoorthy, G.; Lapis, G.; Tran, B.; Vora, S., Data Engineering, 1999. Proceedings., 15th International Conference on , 23-March 1999

Pages:366 - 373

[Abstract]

[PDF Full-Text (92 KB)]

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